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Application/Control No.	Applicant(s)/Patent under Reexamination
10/623,676	HAMMADOU ET AL.
Examiner	Art Unit
Donghee Kang	2811

SEARCHED			
Class	Subclass	Date	Examiner
updated	search	5/26/2005	KANG

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NO)
	DATE	EXMR
east uspat,uspgpub,ibmtdb,epo,jpo,dew	5/26/2005	KANG
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